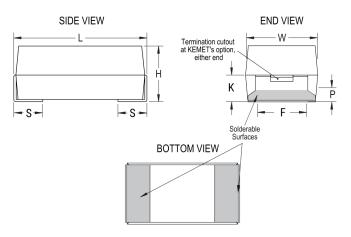


T497 HRA, Tantalum, MnO2 Tantalum, HRA, 47 uF, 10%, 10 VDC, SMD, MnO2, Molded, High Reliability, Medical, N/A, 1.5 Ohms, 5634, Height Max = 2.16mm



Click here for the 3D model.

Dimensions	
Footprint	5634
L	5.59mm +/-0.38mm
W	3.43mm +/-0.38mm
Н	1.78mm +/-0.38mm
S	0.76mm +0.25/-0.13mm
F	3.3mm +/-0.13mm
K	1.02mm MIN
Р	0.51mm MIN

Packaging Specifications	,
Packaging	T&R, 178mm
Packaging Quantity	500

197 HRA nO2 Tantalum MD Chip MD, MnO2, Molded, High Reliability, Medical gh Reliability, Medical
MD Chip MD, MnO2, Molded, High Reliability, Medical
MD, MnO2, Molded, High Reliability, Medical
, , , , , , , , , , , , , , , , , , , ,
gh Reliability, Medical
WARNING: Cancer and reproductive harm - tp://www.p65warnings.ca.gov.
d2e1b8-26dd-4d52-927c-6f9d519011aa
older Coated
WR09/19/29 Style
0
3.63 mg
ote: When solder coated terminations are quired, add an additional 0.38mm (0.015inch) to e tolerances for "L", "W", "H", "K","F" and "S".

Specifications	
Capacitance	47 uF
Capacitance Tolerance	10%
Voltage DC	10 VDC (85C), 6.67 VDC (125C)
Temperature Range	-55/+125°C
Rated Temperature	85°C
Humidity	85C, 85% RH, 1000 Hours, No Load
Dissipation Factor	10% 120Hz 25C
Failure Rate	N/A
Resistance	1.5 Ohms (100kHz 25C)
Ripple Current	258 mA (rms, 100kHz 25C)
Leakage Current	4.7 uA (5min 25°C)
Testing and Reliability	10 Cycles Surge Current Testing At -55C And +85C After Weibull

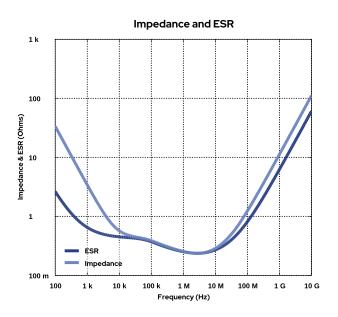
Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

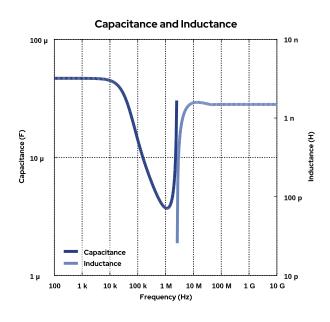


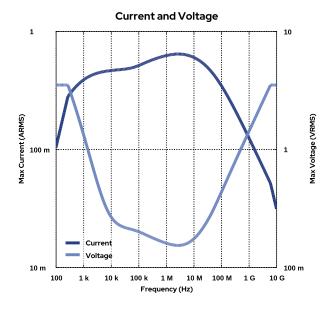
T497 HRA, Tantalum, MnO2 Tantalum, HRA, 47 uF, 10%, 10 VDC, SMD, MnO2, Molded, High Reliability, Medical, N/A, 1.5 Ohms, 5634, Height Max = 2.16mm

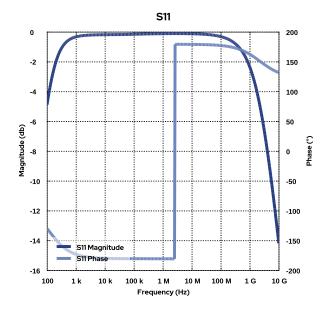
Simulations

For the complete simulation environment please visit K-SIM.



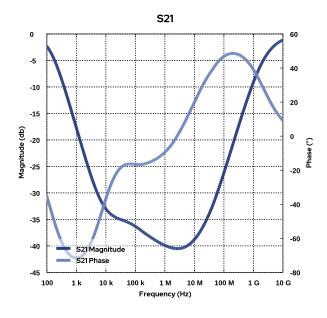








T497 HRA, Tantalum, MnO2 Tantalum, HRA, 47 uF, 10%, 10 VDC, SMD, MnO2, Molded, High Reliability, Medical, N/A, 1.5 Ohms, 5634, Height Max = 2.16mm





T497 HRA, Tantalum, MnO2 Tantalum, HRA, 47 uF, 10%, 10 VDC, SMD, MnO2, Molded, High Reliability, Medical, N/A, 1.5 Ohms, 5634, Height Max = 2.16mm

These are simulations.

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.
- The ESR in the "Temperature Rise vs. Ripple Current" plots is adjusted to each incremental temperature rise before the power and ripple current is calculated.
- The effects shown herein are based on measured data from a multiple part sample of the parts in question.
- Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

 The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages generated at any other
- Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

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If you have any questions please contact K-SIM.